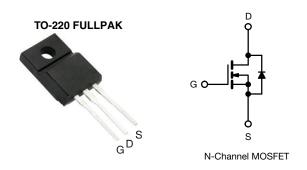
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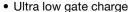
COMPLIANT

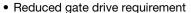
Power MOSFET



PRODUCT SUMMARY					
V _{DS} (V)	500				
$R_{DS(on)}(\Omega)$	V _{GS} = 10 V 0.85				
Q _g max. (nC)	39				
Q _{gs} (nC)	10				
Q _{gd} (nC)	19				
Configuration	Single				

FEATURES





Enhanced 30 V V_{GS} rating

Isolated package

High voltage isolation = 2.5 kV_{RMS} (t = 60 s; f = 60 Hz)

• Sink to lead creepage distance = 4.8 mm

· Repetitive avalanche rated

 Material categorization: for definitions of compliance please see <u>www.vishay.com/doc?99912</u>

DESCRIPTION

This series of low charge power MOSFETs achieve significantly lower gate charge over conventional MOSFETs. Utilizing advanced power MOSFET technology, the device improvements allow for reduced gate drive requirements, faster switching speeds and increased total system savings. These device improvements combined with the proven ruggedness and reliability that are characteristic of MOSFETs offer the designer a new standard in power transistors for switching applications.

The TO-220 FULLPAK eliminates the need for additional insulating hardware. The molding compound used provides a high isolation capability and low thermal resistance between the tab and external heatsink.

ORDERING INFORMATION	
Package	TO-220 FULLPAK
Lead (Pb)-free	IRFI840GLCPbF

PARAMETER			SYMBOL	LIMIT	UNIT	
Drain-source voltage			V_{DS}	500		
Gate-source voltage			V_{GS}	± 30	V	
Continuous dusin surrent		I _D	4.5	А		
Continuous drain current $V_{GS} \text{ at 10 V} \frac{T_C = 25 \text{ °C}}{T_C = 100 \text{ °C}}$			2.9			
Pulsed drain current ^a			I _{DM}	18		
Linear derating factor				0.32	W/°C	
Single pulse avalanche energy b			E _{AS}	300	mJ	
Repetitive avalanche current a			I _{AR}	4.5	Α	
Repetitive avalanche energy ^a			E _{AR}	4.0	mJ	
Maximum power dissipation $T_C = 25 ^{\circ}C$			P_{D}	40	W	
Peak diode recovery dV/dt ^c			dV/dt	3.5	V/ns	
Operating junction and storage temperature range			T _J , T _{stg}	-55 to +150	°C	
Soldering recommendations (peak temperature) ^d	For 10 s			300		
Mounting torque	M3 screw			0.6	Nm	

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11)
- b. V_{DD} = 50 V, starting T_J = 25 °C, L = 26 mH, R_G = 25 Ω , I_{AS} = 4.5 A (see fig. 12)
- c. $I_{SD} \le 8.0$ A, $dI/dt \le 100$ A/µs, $V_{DD} \le V_{DS}$, $T_J \le 150$ °C
- d. 1.6 mm from case



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THERMAL RESISTANCE RATINGS				
PARAMETER	SYMBOL	TYP.	MAX.	UNIT
Maximum junction-to-ambient	R _{thJA}	-	65	°C/W
Maximum junction-to-case (drain)	R _{thJC}	-	3.1	G/ VV

PARAMETER	SYMBOL	TES	T CONDITIONS	MIN.	TYP.	MAX.	UNIT
Static							
Drain-ssource breakdown voltage	V _{DS}	V _{GS} =	= 0 V, I _D = 250 μA	500	-	-	V
V _{DS} temperature coefficient	$\Delta V_{DS}/T_{J}$	Reference	e to 25 °C, I _D = 1 mA	-	0.63	-	V/°C
Gate-source threshold voltage	V _{GS(th)}	V _{DS} =	· V _{GS} , I _D = 250 μA	2.0	-	4.0	V
Gate-source leakage	I _{GSS}	,	V _{GS} = ± 20 V	-	-	± 100	nA
Zoro goto voltago droin aurrent		V _{DS} =	= 500 V, V _{GS} = 0 V	-	-	25	
Zero gate voltage drain current	I _{DSS}	$V_{DS} = 400 \text{ V}$	', V _{GS} = 0 V, T _J = 125 °C	-	-	250	μA
Drain-source on-state resistance	R _{DS(on)}	V _{GS} = 10 V	I _D = 2.7 A ^b	-	-	0.85	mΩ
Forward transconductance	9 _{fs}	V _{DS} =	50 V, I _D = 4.8 A ^b	4.0	-	-	S
Dynamic							
Input capacitance	C _{iss}		$V_{GS} = 0 V$,	-	1100	-	
Output capacitance	C _{oss}		$V_{DS} = 25 \text{ V},$	-	170	-	pF
Reverse transfer capacitance	C_{rss}	f = 1.	.0 MHz, see fig. 5	=.	18	-	рг
Drain to sink capacitance	С		f = 1.0 MHz	-	12	-	
Total gate charge	Qg			-	-	39	
Gate-source charge	Q_{gs}	$V_{GS} = 10 \text{ V}$	$I_D = 8.0 \text{ A}, V_{DS} = 400 \text{ V}$ see fig. 6 and 13 b	=.	-	10	nC
Gate-drain charge	Q _{gd}		occ lig. o and ro	=	-	19	
Turn-on delay time	t _{d(on)}			-	12	-	
Rise time	t _r			-	25	-	
Turn-off delay time	t _{d(off)}	V _{DD} = 250 V, I _D = 8.0 A, R _G = 9.1Ω, Rr _D = 30 Ω, V _{GS} = 10 V, see fig. 10 b		=	27	-	- ns
Fall time	t _f			=	19	-	
Gate input resistance	Rg	f = 1	MHz, open drain	0.7	-	3.7	Ω
Internal drain inductance	L _D	Between lead, 6 mm (0.25") from		-	4.5	-	-11
Internal source inductance	L _S	package and die cont		-	7.5	-	nH
Drain-Source Body Diode Characteristic	es						
Continuous source-drain diode current	I _S	MOSFET sym showing the		-	-	4.5	_
Pulsed diode forward current ^a	I _{SM}	integral reverse p - n junction diode		-	-	18	A
Body diode voltage	V _{SD}	T _J = 25 °C, I _S = 4.5 A, V _{GS} = 0 V ^b		-	-	2.0	V
Body diode reverse recovery time	t _{rr}	- 4		490	740	ns	
Body diode reverse recovery charge	Q _{rr}	$T_J = 25 ^{\circ}\text{C}, I_F = 8.0 \text{A}, dI/dt = 100 \text{A/}\mu\text{s}^{\text{b}}$		-	3.0	4.5	μC
Forward turn-on time	t _{on}	Intrinsic turn-on time is negligible (turn-on is dominated by L _S and L _D)			L _D)		

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11)
- b. Pulse width \leq 300 µs; duty cycle \leq 2 %



TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

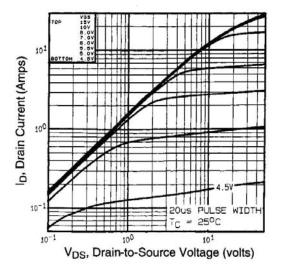


Fig. 1 - Typical Output Characteristics, T_C = 25 °C

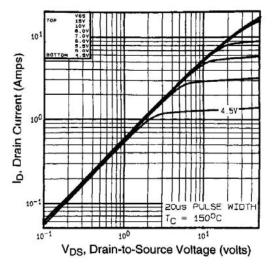


Fig. 2 - Typical Output Characteristics, $T_C = 150$ °C

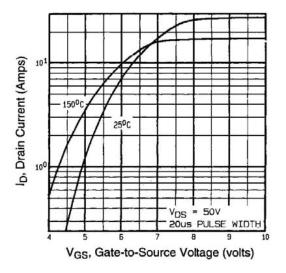


Fig. 3 - Typical Transfer Characteristics

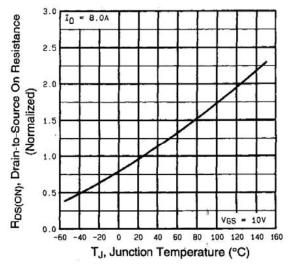


Fig. 4 - Normalized On-Resistance vs. Temperature



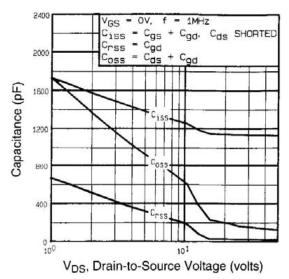


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

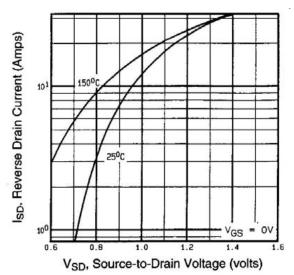


Fig. 7 - Typical Source-Drain Diode Forward Voltage

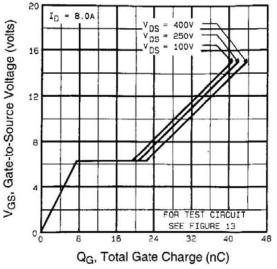


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

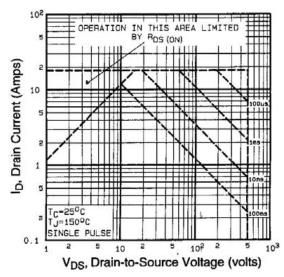


Fig. 8 - Maximum Safe Operating Area



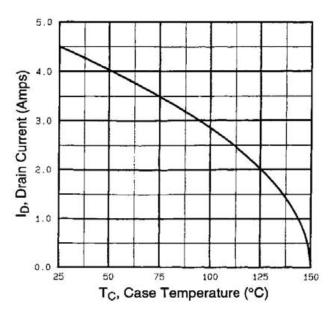


Fig. 9 - Maximum Drain Current vs. Case Temperature

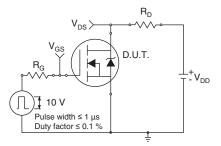


Fig. 10a - Switching Time Test Circuit

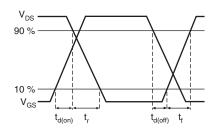


Fig. 10b - Switching Time Waveforms

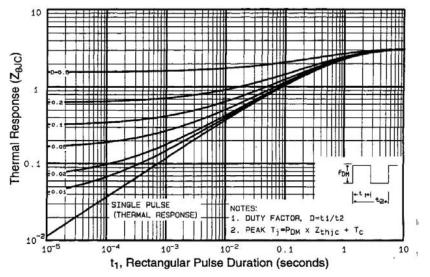


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case



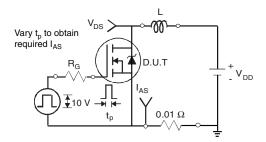


Fig. 12a - Unclamped Inductive Test Circuit

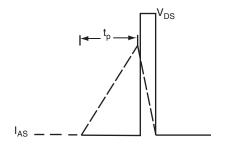


Fig. 12b - Unclamped Inductive Waveforms

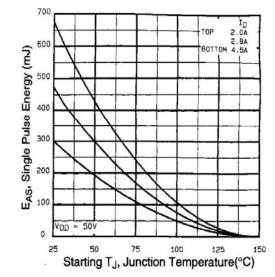


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

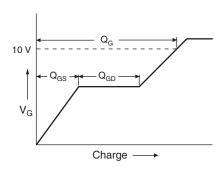


Fig. 13a - Basic Gate Charge Waveform

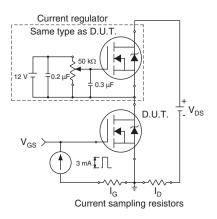
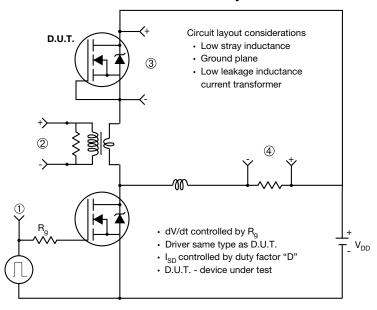


Fig. 13b - Gate Charge Test Circuit



Peak Diode Recovery dV/dt Test Circuit



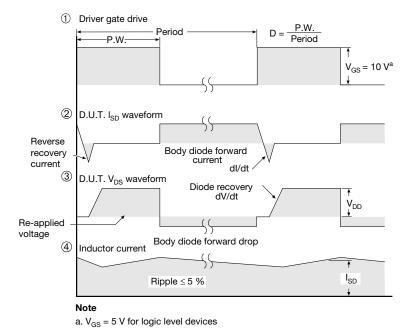


Fig. 14 - For N-Channel

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TO-220 FULLPAK (High Voltage)

OPTION 1: FACILITY CODE = 9



		MILLIMETERS	
DIM.	MIN.	NOM.	MAX.
Α	4.60	4.70	4.80
b	0.70	0.80	0.91
b1	1.20	1.30	1.47
b2	1.10	1.20	1.30
С	0.45	0.50	0.63
D	15.80	15.87	15.97
е		2.54 BSC	
E	10.00	10.10	10.30
F	2.44	2.54	2.64
G	6.50	6.70	6.90
L	12.90	13.10	13.30
L1	3.13	3.23	3.33
Q	2.65	2.75	2.85
Q1	3.20	3.30	3.40
ØR	3.08	3.18	3.28

- 1. To be used only for process drawing
- 2. These dimensions apply to all TO-220 FULLPAK leadframe versions 3 leads
- 3. All critical dimensions should C meet $C_{pk} > 1.33$
- 4. All dimensions include burrs and plating thickness
- 5. No chipping or package damage
- 6. Facility code will be the 1st character located at the 2nd row of the unit marking



OPTION 2: FACILITY CODE = Y



	MILLIMETERS		MILLIMI	INCHES		
DIM.	MIN.	MAX.	MIN.	MAX.		
Α	4.570	4.830	0.180	0.190		
A1	2.570	2.830	0.101	0.111		
A2	2.510	2.850	0.099	0.112		
b	0.622	0.890	0.024	0.035		
b2	1.229	1.400	0.048	0.055		
b3	1.229	1.400	0.048	0.055		
С	0.440	0.629	0.017	0.025		
D	8.650	9.800	0.341	0.386		
d1	15.88	16.120	0.622	0.635		
d3	12.300	12.920	0.484	0.509		
Е	10.360	10.630	0.408	0.419		
е	2.54	2.54 BSC		0.100 BSC		
L	13.200	13.730	0.520	0.541		
L1	3.100	3.500	0.122	0.138		
n	6.050	6.150	0.238	0.242		
ØΡ	3.050	3.450	0.120	0.136		
u	2.400	2.500	0.094	0.098		
V	0.400	0.500	0.016	0.020		

ECN: E19-0180-Rev. D, 08-Apr-2019

DWG: 5972

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- 6. Facility code will be the 1st character located at the 2nd row of the unit marking



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